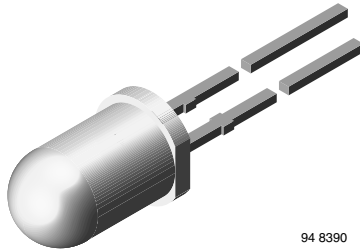


## High Speed Infrared Emitting Diode, RoHS Compliant, 870 nm, GaAIAs Double Hetero



94 8390

### DESCRIPTION

TSFF5410 is an infrared, 870 nm emitting diode in GaAIAs double hetero (DH) technology with high radiant power and high speed, molded in a clear, untinted plastic package.

### FEATURES

- Package type: leaded
- Package form: T-1 $\frac{3}{4}$
- Dimensions (in mm):  $\varnothing$  5
- Leads with stand-off
- Peak wavelength:  $\lambda_p = 870$  nm
- High reliability
- High radiant power
- High radiant intensity
- Angle of half intensity:  $\varphi = \pm 22^\circ$
- Low forward voltage
- Suitable for high pulse current operation
- High modulation bandwidth:  $f_c = 24$  MHz
- Good spectral matching to Si photodetectors
- Lead (Pb)-free component in accordance with RoHS 2002/95/EC and WEEE 2002/96/EC


**RoHS**  
COMPLIANT

### APPLICATIONS

- Infrared video data transmission between camcorder and TV set
- Free air data transmission systems with high modulation frequencies or high data transmission rate requirements

### PRODUCT SUMMARY

COMPONENT	$I_e$ (mW/sr)	$\varphi$ (deg)	$\lambda_p$ (nm)	$t_r$ (ns)
TSFF5410	70	$\pm 22$	870	15

#### Note

Test conditions see table "Basic Characteristics"

### ORDERING INFORMATION

ORDERING CODE	PACKAGING	REMARKS	PACKAGE FORM
TSFF5410	Bulk	MOQ: 4000 pcs, 4000 pcs/bulk	T-1 $\frac{3}{4}$

#### Note

MOQ: minimum order quantity

### ABSOLUTE MAXIMUM RATINGS

PARAMETER	TEST CONDITION	SYMBOL	VALUE	UNIT
Reverse voltage		$V_R$	5	V
Forward current		$I_F$	100	mA
Peak forward current	$t_p/T = 0.5, t_p = 100 \mu s$	$I_{FM}$	200	mA
Surge forward current	$t_p = 100 \mu s$	$I_{FSM}$	1	A
Power dissipation		$P_V$	180	mW



ABSOLUTE MAXIMUM RATINGS				
PARAMETER	TEST CONDITION	SYMBOL	VALUE	UNIT
Junction temperature		$T_j$	100	$^{\circ}\text{C}$
Operating temperature range		$T_{\text{amb}}$	- 40 to + 85	$^{\circ}\text{C}$
Storage temperature range		$T_{\text{stg}}$	- 40 to + 100	$^{\circ}\text{C}$
Soldering temperature	$t \leq 5 \text{ s}$ , 2 mm from case	$T_{\text{sd}}$	260	$^{\circ}\text{C}$
Thermal resistance junction/ambient	J-STD-051, leads 7 mm, soldered on PCB	$R_{\text{thJA}}$	230	K/W

**Note**

$T_{\text{amb}} = 25 \text{ }^{\circ}\text{C}$ , unless otherwise specified

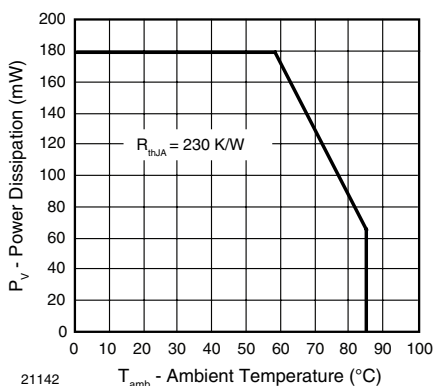


Fig. 1 - Power Dissipation Limit vs. Ambient Temperature

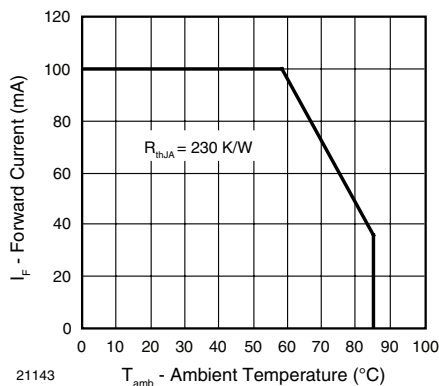


Fig. 2 - Forward Current Limit vs. Ambient Temperature

BASIC CHARACTERISTICS						
PARAMETER	TEST CONDITION	SYMBOL	MIN.	TYP.	MAX.	UNIT
Forward voltage	$I_F = 100 \text{ mA}$ , $t_p = 20 \text{ ms}$	$V_F$		1.5	1.8	V
	$I_F = 1 \text{ A}$ , $t_p = 100 \text{ } \mu\text{s}$	$V_F$		2.3	3.0	V
Temperature coefficient of $V_F$	$I_F = 1 \text{ mA}$	$\text{TK}_{V_F}$		- 1.8		mV/K
Reverse current	$V_R = 5 \text{ V}$	$I_R$			10	$\mu\text{A}$
Junction capacitance	$V_R = 0 \text{ V}$ , $f = 1 \text{ MHz}$ , $E = 0$	$C_j$		125		pF
Radiant intensity	$I_F = 100 \text{ mA}$ , $t_p = 20 \text{ ms}$	$I_e$	45	70	135	mW/sr
	$I_F = 1 \text{ A}$ , $t_p = 100 \text{ } \mu\text{s}$	$I_e$		700		mW/sr
Radiant power	$I_F = 100 \text{ mA}$ , $t_p = 20 \text{ ms}$	$\phi_e$		50		mW
Temperature coefficient of $\phi_e$	$I_F = 100 \text{ mA}$	$\text{TK}_{\phi_e}$		- 0.35		%/K
Angle of half intensity		$\phi$		$\pm 22$		deg
Peak wavelength	$I_F = 100 \text{ mA}$	$\lambda_p$		870		nm
Spectral bandwidth	$I_F = 100 \text{ mA}$	$\Delta\lambda$		40		nm
Temperature coefficient of $\lambda_p$	$I_F = 100 \text{ mA}$	$\text{TK}_{\lambda_p}$		0.25		nm/K
Rise time	$I_F = 100 \text{ mA}$	$t_r$		15		ns
Fall time	$I_F = 100 \text{ mA}$	$t_f$		15		ns
Cut-off frequency	$I_{\text{DC}} = 70 \text{ mA}$ , $I_{\text{AC}} = 30 \text{ mA pp}$	$f_c$		24		MHz
Virtual source diameter		$d$		2.1		mm

**Note**

$T_{\text{amb}} = 25 \text{ }^{\circ}\text{C}$ , unless otherwise specified

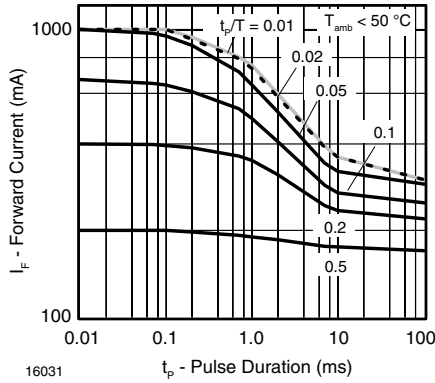
**BASIC CHARACTERISTICS**
 $T_{amb} = 25\text{ }^{\circ}\text{C}$ , unless otherwise specified


Fig. 3 - Pulse Forward Current vs. Pulse Duration

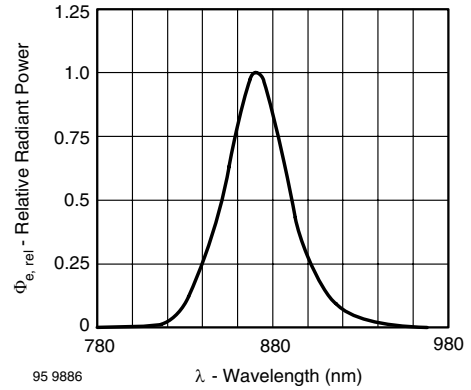


Fig. 6 - Relative Radiant Power vs. Wavelength

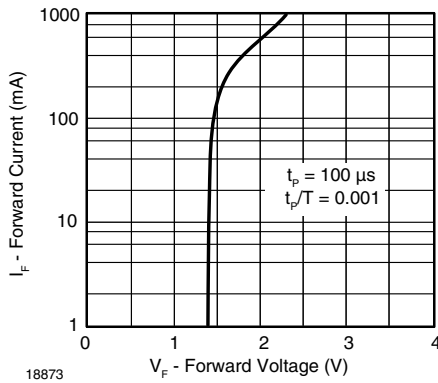


Fig. 4 - Forward Current vs. Forward Voltage

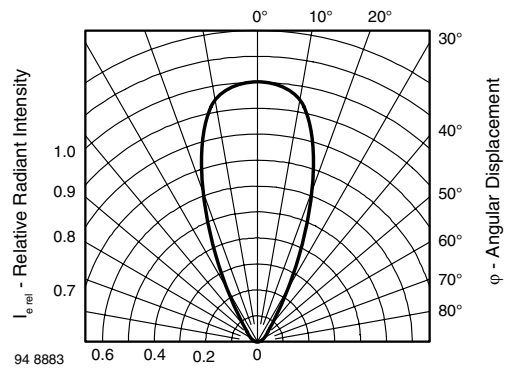


Fig. 7 - Relative Radiant Intensity vs. Angular Displacement

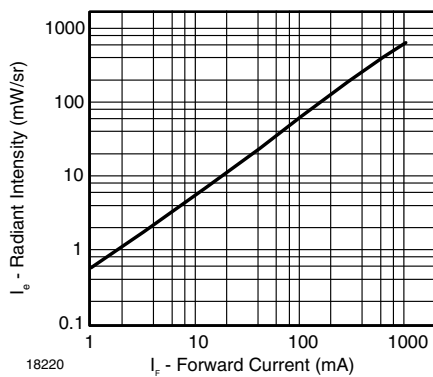


Fig. 5 - Radiant Intensity vs. Forward Current

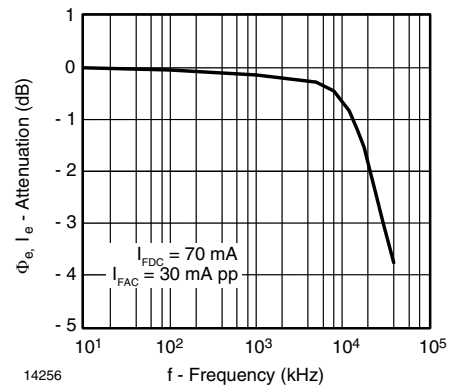


Fig. 8 - Attenuation vs. Frequency

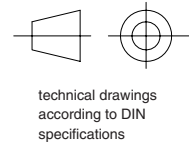
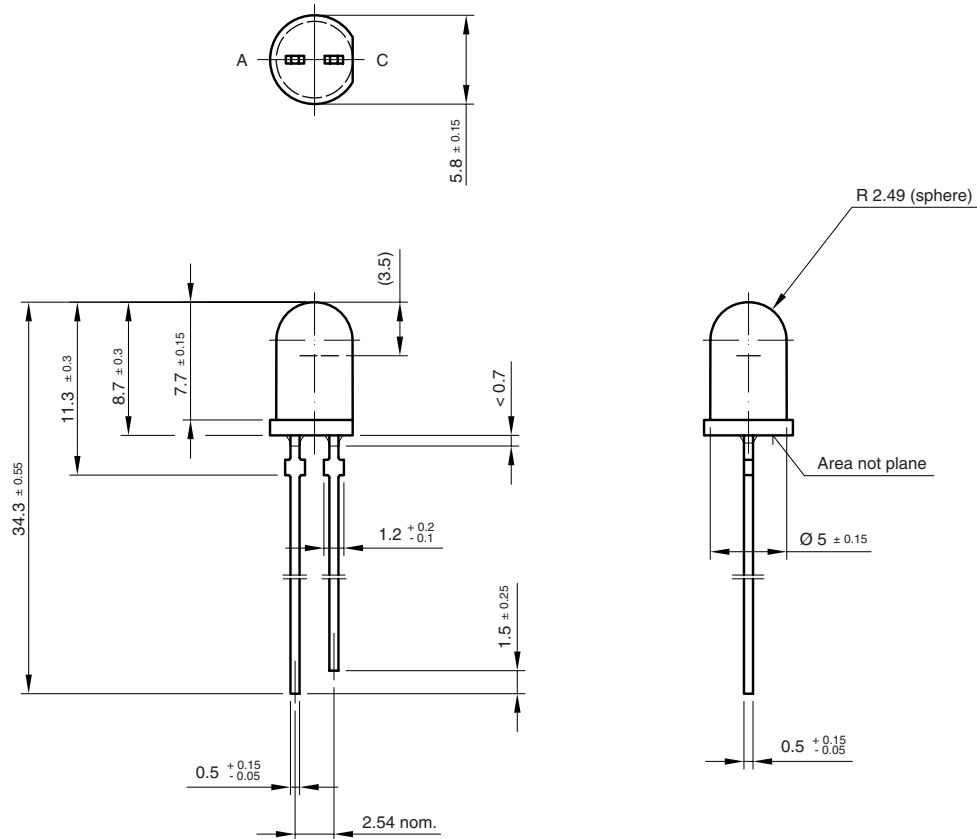
# TSFF5410

Vishay Semiconductors

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## PACKAGE DIMENSIONS in millimeters



6.544-5258.06-4  
Issue: 2; 08.11.99  
95 11260



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